

# **TEST REPORT**

Product Name: Module

Trade Mark: CINTERION

Model No. / HVIN: PLS63-X

FCC ID: QIPPLS63-X

IC: 7830A-PLS63X

Report Number: 200722024EMC-1

**Test Standards:** FCC 47 CFR Part 15 Subpart B

ICES-003 Issue 6

Test Result: PASS

Date of Issue: February 25, 2021

#### Prepared for:

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#### Prepared by:

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Date:

February 25, 2021

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# **Version**

Version No.	Date	Description
V1.0	February 25, 2021	Original





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# 1. GENERAL INFORMATION 1.1 CLIENT INFORMATION

Applicant:	Thales DIS AIS Deutschland GmbH
Address of Applicant:	Siemensdamm 50, 13629 Berlin, Germany
Manufacturer:	Thales DIS AIS Deutschland GmbH
Address of Manufacturer:	Werinherstr, 81, 81541 Munich, Germany

### 1.2 EUT INFORMATION

# 1.2.1 General Description of EUT

	iption of Eo.
Product Name:	Module
Model No. / HVIN:	PLS63-X
Trade Mark:	CINTERION
DUT Stage:	Production Unit
Rated Voltage:	□ DC3.8V provide from adaptor 120V~60Hz
Classification of digital devices:	Class B
Highest Internal Frequency:	2.6 GHz
Sample Received Date:	October 19, 2020
Sample Tested Date:	September 1, 2020 to October 26, 2020
EUT identification	200722024-A01/2
Firmware number	MDM9607.TX.1.0-00097-STD.PROD-1.366947.1.367976.1

# 1.2.2 Description of Accessories

None

#### 1.3 DESCRIPTION OF SUPPORT UNITS

The EUT has been tested with associated equipment below.

1) Support Equipment

Description	Manufacturer	Model No.	Serial Number	Supplied by
Adaptor	N/A	CD139	20359	Applicant
PCB board	N/A	DSB75	-	Applicant
PCB board	N/A	AH8	/	Applicant
50 ohm terminal	N/A	N/A	N/A	UnionTrust

## 2) Support Cable

Cable No.	Description	Connector	Length	Supplied by

# 1.4 TEST LOCATION

#### Shenzhen UnionTrust Quality and Technology Co., Ltd.

Address: Unit D/E of 9/F and 16/F, Block A, Building 6, Baoneng science and technology park, Longhua district,

Shenzhen, China 518109

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#### 1.5 TEST FACILITY

The test facility is recognized, certified, or accredited by the following organizations:

#### CNAS-Lab Code: L9069

The measuring equipment utilized to perform the tests documented in this report has been calibrated once a year or in accordance with the manufacturer's recommendations, and is traceable under the ISO/IEC/EN 17025 to international or national standards. Equipment has been calibrated by accredited calibration laboratories.

### A2LA-Lab Certificate No.: 4312.01

Shenzhen UnionTrust Quality and Technology Co., Ltd. has been accredited by A2LA for technical competence in the field of electrical testing, and proved to be in compliance with ISO/IEC 17025: 2005 General Requirements for the Competence of Testing and Calibration Laboratories and any additional program requirements in the identified field of testing.

#### **ISED Wireless Device Testing Laboratories**

CAB identifier: CN0032

#### FCC Accredited Lab.

**Designation Number: CN1194** 

Test Firm Registration Number: 259480

### 1.6 DEVIATION FROM STANDARDS

None.

## 1.7 ABNORMALITIES FROM STANDARD CONDITIONS

None.

#### 1.8 OTHER INFORMATION REQUESTED BY THE CUSTOMER

None.

#### 1.9 MEASUREMENT UNCERTAINTY

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the Product as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

No.	ltem	Measurement Uncertainty
1	Conducted emission 9KHz-150KHz	±3.2 dB
2	Conducted emission 150KHz-30MHz	±2.7 dB
3	Radiated emission 9KHz-30MHz	± 4.7 dB
4	Radiated emission 30MHz-1GHz	± 4.6 dB
5	Radiated emission 1GHz-18GHz	± 4.4 dB
6	Radiated emission 18GHz-26GHz	± 4.6 dB
7	Radiated emission 26GHz-40GHz	± 4.6 dB



# 2. TEST SUMMARY

FCC 47 CFR Part 15 Subpart B Test Cases						
Test Item Test Requirement Test Method Result						
Conducted Emission	FCC 47 CFR Part 15.107 ICES-003 Issue 6 Section 6.1	ANSI C63.4-2014	See Note			
Radiated Emission	FCC 47 CFR Part 15.109 ICES-003 Issue 6 Section 6.2	ANSI C63.4-2014	PASS			

#### Note:

#### Difference description:

- 1) There are hardware differences between PLS63-X and PLS83-X Module. For detailed PCB board and component differences, see the difference statement document
- 2) The HSPA Category level of PLS63-X is 8, different from PLS83-X Cat 14.

#### **Test Plan:**

1) According to the difference description, PLS63-X shares the same data from the PLS83-X original report (Report No.: 200722022EMC-1), and test the new data of the Radiated emission items.

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# 3. EQUIPMENT LIST

	Radiated Emission Test Equipment List							
Used	Equipment	Manufacturer	Model No.	Serial Number	Cal. date (mm dd, yyyy)	Cal. Due date (mm dd, yyyy)		
$\boxtimes$	3M Chamber & Accessory Equipment	ETS-LINDGREN	3M	N/A	Dec. 03, 2018	Dec. 03, 2021		
$\boxtimes$	Receiver	R&S	ESIB26	100114	Nov. 24, 2019	Nov. 23, 2020		
	Loop Antenna	ETS-LINDGREN	6502	00202525	Nov. 24, 2019	Nov. 23, 2020		
$\boxtimes$	Broadband Antenna	ETS-LINDGREN	3142E	00201566	Nov. 16, 2019	Nov. 15, 2020		
$\boxtimes$	6dB Attenuator	Talent	RA6A5-N- 18	18103001	Nov. 16, 2019	Nov. 15, 2020		
$\boxtimes$	Preamplifier	HP	8447F	2805A02960	Nov. 16, 2019	Nov. 15, 2020		
	Broadband Antenna (Pre-amplifier)	ETS-LINDGREN	3142E-PA	00201891	Nov. 24, 2019	Nov. 23, 2020		
	6dB Attenuator	Talent	RA6A5-N- 18	18103002	Nov. 24, 2019	Nov. 23, 2020		
	Horn Antenna	ETS-LINDGREN	3117	00164202	Nov. 24, 2019	Nov. 23, 2020		
X	Horn Antenna (Pre-amplifier)	ETS-LINDGREN	3117-PA	00201874	Nov. 16, 2019	Nov. 15, 2020		
	Horn Antenna	ETS-LINDGREN	3116C	00200180	Jun. 19, 2020	Jun. 18, 2021		
	Horn Antenna (Pre-amplifier)	ETS-LINDGREN	3116C-PA	00202652	Nov. 16, 2019	Nov. 15, 2020		
	Multi device Controller	ETS-LINDGREN	7006-001	00160105	N/A	N/A		
$\boxtimes$	Test Software	Audix	e3	Software Version: 9.160323				

	Conducted Emission Test Equipment List							
Used	Equipment	Manufacturer	Model No.	Serial Number	Cal. date (mm dd, yyyy)	Cal. Due date (mm dd, yyyy)		
$\boxtimes$	Receiver	R&S	ESR7	1316.3003K07 -101181-K3	Nov. 24, 2019	Nov. 23, 2020		
$\boxtimes$	Pulse Limiter	R&S	ESH3-Z2	0357.8810.54	Nov. 24, 2019	Nov. 23, 2020		
$\boxtimes$	LISN	R&S	ESH2-Z5	860014/024	Nov. 24, 2019	Nov. 23, 2020		
	LISN	ETS-Lindgren	3816/2SH	00201088	Nov. 24, 2019	Nov. 23, 2020		
$\boxtimes$	Test Software	Audix	e3	Sof	tware Version: 9.160	0323		



# 4. TEST CONFIGURATION

# 4.1 ENVIRONMENTAL CONDITIONS FOR TESTING

# 4.1.1 Normal or Extreme Test Conditions

<b>Environment Parameter</b>	Selected Values During Tests					
Test Condition	Ambient					
rest Condition	Temperature (°C)	Voltage (V)	Relative Humidity (%)			
NT/NV	+15 to +35	3.2 to 4.5	20 to 75			
Remark:  1) NV: Normal Voltage; NT: Normal Temperature						

# 4.1.2 Record of Normal Environment

Test Item	Temperature (°C)	Relative Humidity (%)	Pressure (kPa)	Tested by
Conducted Emission	24.8	60	99.4	Tripp Jiang
Radiated Emission	25.6	52	100.02	Asia Yan

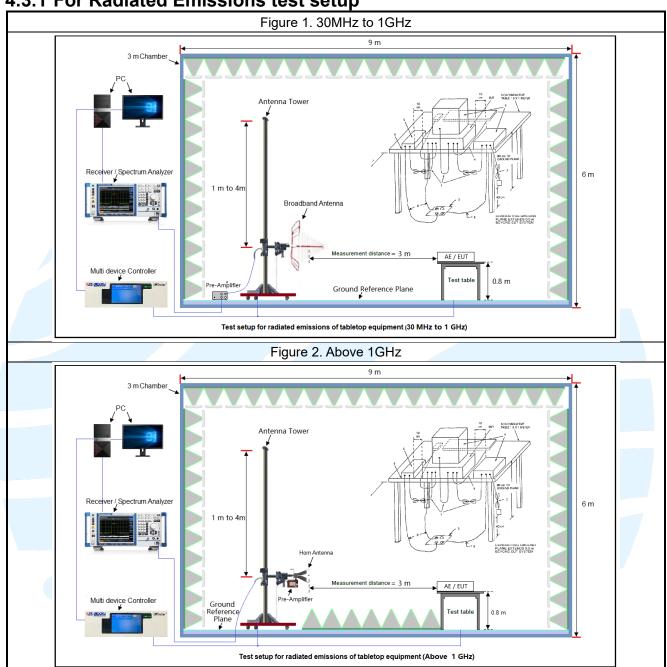
## **4.2TEST MODES**

 112 1 20 1 111 0 5 2 0		
Test Item	EMI Test Modes	
	Mode 1: Charging from adapter + GSM850+ GPS on	
 Dedicted Fusionism	Mode 2: Charging from adapter + WCDMA II+ GPS on	
Radiated Emission	Mode 3: Charging from adapter + LTE B2+ GPS on	
	Mode 4: ESIM select worst mode from mode1~3	
	Mode 1: Charging from adapter + GSM850+ GPS on	
One divisted Fraincian	Mode 2: Charging from adapter + WCDMA II+ GPS on	
Conducted Emission	Mode 3: Charging from adapter + LTE B2+ GPS on	
	Mode 4: ESIM select worst mode from mode1~3	
Remark: The above test modes in boldface were the worst cases, only the test data of these modes were reported.		



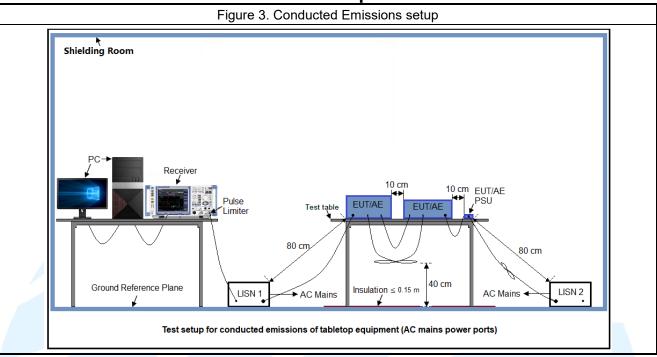
# **4.3TEST SETUP**

# 4.3.1 For Radiated Emissions test setup





4.3.2 For Conducted Emissions test setup



## 4.4 SYSTEM TEST CONFIGURATION

All readings are extrapolated back to the equivalent three meter reading using inverse scaling with distance. Analyzer resolution is 100 kHz or greater for frequencies below 1000MHz. The resolution is 1 MHz or greater for frequencies above 1000MHz. The spurious emissions more than 20 dB below the permissible value are not reported.

Radiated emission measurement were performed from the lowest radio frequency signal generated in the device which is greater than 9 kHz to the tenth harmonic (according to KDB 896810 D02 SDoC FAQ v01r01) of the highest fundamental frequency or to 40 GHz, whichever is lower.



5. REFERENCE DOCUMENTS FOR TESTING

No.	Identity	Document Title
1	FCC 47 CFR Part15 Subpart B	Unintentional Radiators
2	ICES-003 Issue 6	Information Technology Equipment (Including Digital Apparatus)  —Limits and Methods of Measurement
3	ANSI C63.4-2014	American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz
4	KDB 174176 D01 Line Conducted FAQ v01r01	AC power-line conducted emission frequency asked questions
5	KDB 896810 D02 SDoC FAQ v01r02	Supplier's Declaration of Conformity frequency asked questions





# 6. EMC REQUIREMENTS SPECIFICATION 6.1 RADIATED EMISSION

FCC 47 CFR Part 15.109 **Test Requirement:** ICES-003 Issue 6 Clause 6.2

**Test Method:** ANSI C63.4-2014

**Receiver Setup:** 

Frequency: (f)	Detector type	Measurement receiver bandwidth		
(MHz)	Detector type	RBW	VBW	
30 ≤ f ≤ 1 000	Quasi Peak	120 kHz	300 kHz	
f >1000	Peak	1 MHz	3 MHz	
f ≥1000	Average	1 MHz	3 MHz	

#### Measured frequency range

Highest frequency generated or used in the device or on which the device operates or tunes (MHz)	Upper frequency of measurement range (MHz)	
Below 1.705	30.	
1.705-108	1000.	
108-500	2000.	
500-1000	5000.	
Above 1000	5th harmonic of the highest frequency or 40 GHz, whichever is lower.	

#### Limits:

Limits for Class B devices

	Eroguenov (MHz)	limits at 3m (dBμV/m)		
	Frequency (MHz)	QP Detector	PK Detector	AV Detector
	30-88	40.0	<b>/</b>	-
	88-216	43.5	-	
	216-960	46.0	- / /	-
	960 to 1000	54.0	<i>-</i> -	-
Ī	Above 1000		74.0	54.0

#### Remark:

- The lower limit shall apply at the transition frequencies.
- Emission level (dB $\mu$ V/m) = 20 log Emission level ( $\mu$ V/m).
- For frequencies above 1000 MHz, the field strength limits are based on average detector, however, the peak field strength of any emission shall not exceed the maximum permitted average limits, specified above by more than 20 dB under any condition of modulation.

**Test Setup:** Refer to section 4.3.1 for details.

#### **Test Procedures:**

- From 30 MHz to 1GHz test procedure as below:
- The Product was placed on the non-conductive turntable 0.8 m above the ground at a chamber.
- Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 120 kHz RBW. Record the maximum field strength of all the pre-scan process in the full band when the antenna is varied between 1~4 m in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.
- For each frequency whose maximum record was higher or close to limit, measure its QP value: vary the antenna's height and rotate the turntable from 0 to 360 degrees to find the height and degree where Product radiated the maximum emission, then set the test frequency analyzer/receiver to QP Detector and specified bandwidth with Maximum Hold Mode, and record the maximum value.
- Above 1GHz test procedure as below:
- The Product was placed on the non-conductive turntable 0.8 m above the ground at a chamber.
- Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 1MHz RBW. Record the

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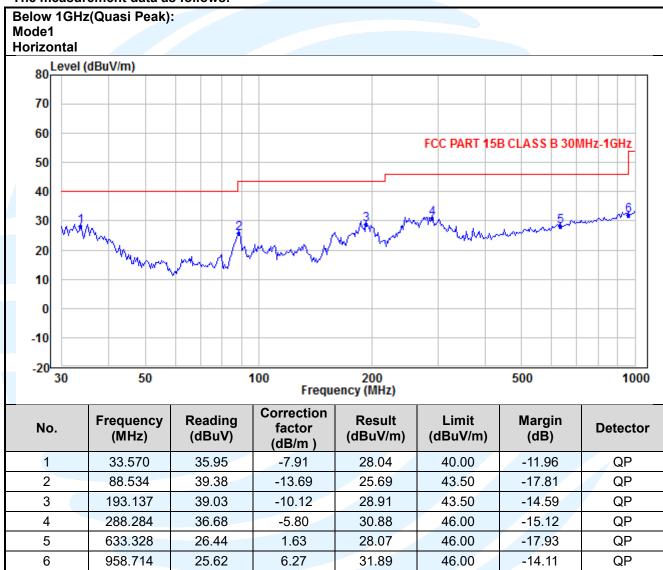
maximum field strength of all the pre-scan process in the full band when the antenna is varied in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.

3) For each frequency whose maximum record was higher or close to limit, measure its AV value: rotate the turntable from 0 to 360 degrees to find the degree where Product radiated the maximum emission, then set the test frequency analyzer/receiver to AV value and specified bandwidth with Maximum Hold Mode, and record the maximum value.

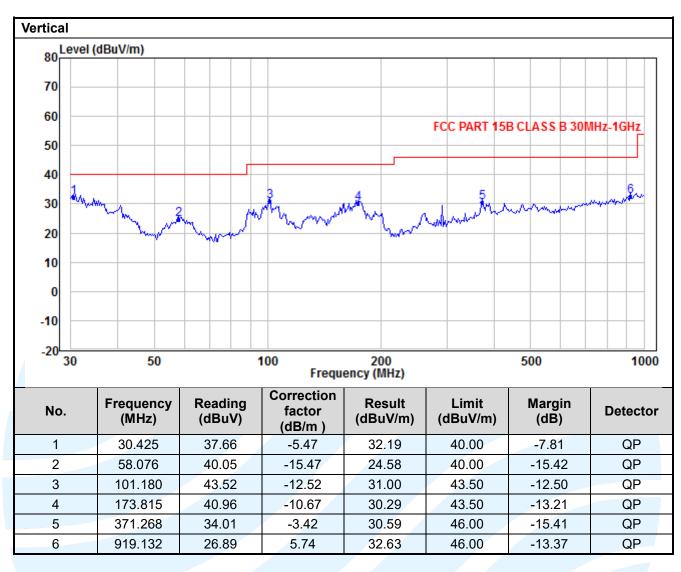
**Equipment Used:** Refer to section 3 for details.

Test Result: Pass

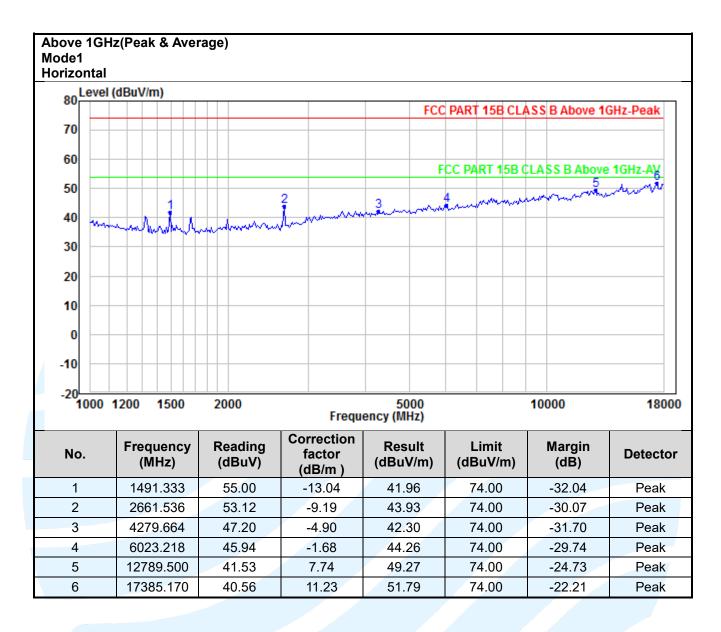
The measurement data as follows:



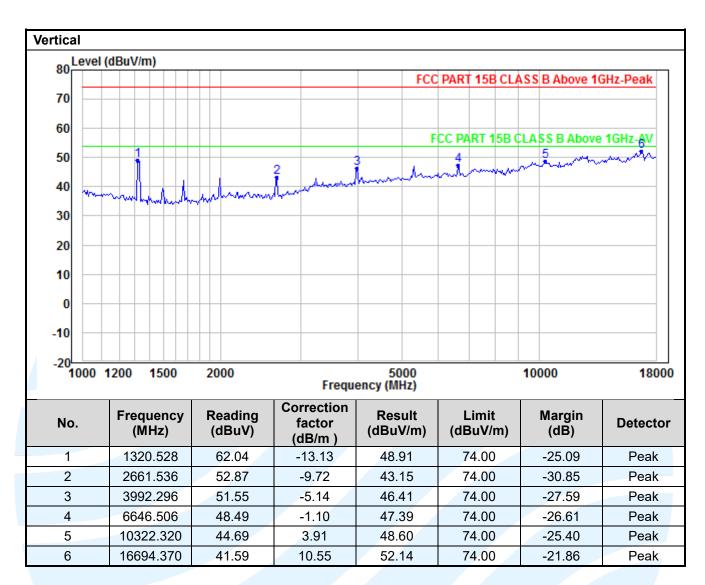












#### Remark:

- 1. Correct Factor = Antenna Factor + Cable Loss Amplifier Gain, the value was added to Original Receiver Reading by the software automatically.
- 2. Result = Reading + Correct Factor.
- 3. Margin = Result Limit
- 4. For Radiated Emission above 18GHz, there was not any unwanted emission detected.
- 5. As shown in this section, for frequencies above 1GHz, the field strength limits are based on average limits. However, the peak field strength of any emission shall not exceed the maximum permitted average limits specified above by more than 20 dB under any condition of modulation. So, only the peak measurements were shown in the report.

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### **6.2 CONDUCTED EMISSION**

**Test Requirement:** FCC 47 CFR Part 15.107 ICES-003 Issue 6 Section 6.1

Test Method: ANSI C63.4-2014

Limits:

Limits for Class B devices

Frequency range	Limits (dB(μV)		
(MHz)	Quasi-peak	Average	
0,15 to 0,50	66 to 56	56 to 46	
0,50 to 5	56	46	
5 to 30	60	50	

#### Remark:

1. The lower limit shall apply at the transition frequencies.

2. The limit decreases linearly with the logarithm of the frequency in the range 0.15 to 0.50 MHz.

**Test Setup:** Refer to section 4.3.2 for details.

#### **Test Procedures:**

1) The Product was placed on a nonconductive table 0.8 m above the horizontal ground reference plane, and 0.4 m from the vertical ground reference plane, and connected to the main through Line Impedance Stability Network (L.I.S.N).

2) The RBW of the receiver was set at 9 kHz in 150 kHz ~ 30MHz with Peak and AVG detector in Max Hold mode. Run the receiver's pre-scan to record the maximum disturbance generated from Product in all power lines in the full band.

3) For each frequency whose maximum record was higher or close to limit, measure its QP and AVG values and record.

**Equipment Used:** Refer to section 3 for details.

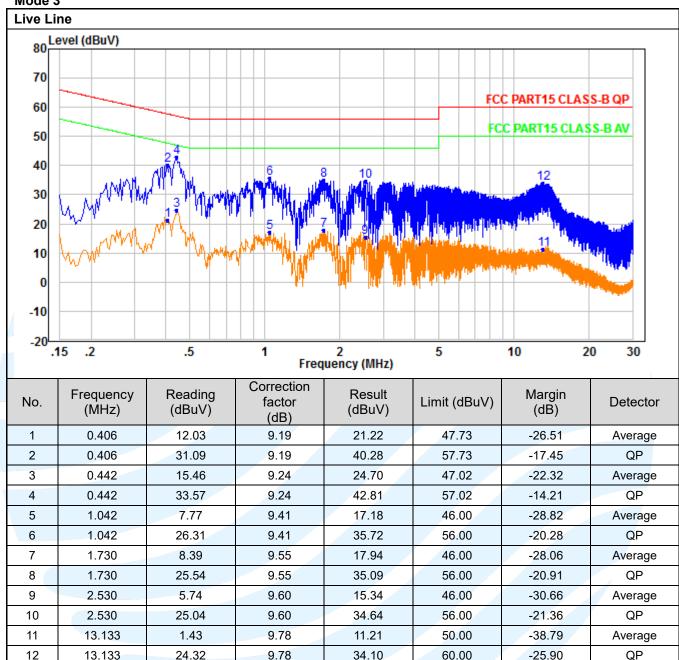
Test Result: Pass



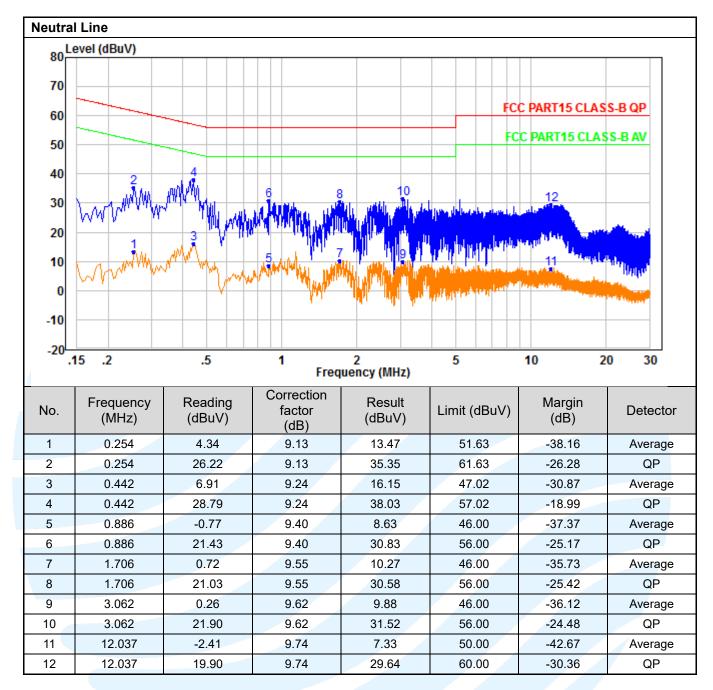
#### The measurement data as follows:

Quasi Peak and Average:

Mode 3







#### Remark:

- Correct Factor = LISN Factor + Cable Loss + Pulse Limiter Factor, the value was added to Original Receiver Reading by the software automatically.
- 2. Result = Reading + Correct Factor.
- 3. Margin = Result Limit
- 4. An initial pre-scan was performed on the Phase and neutral lines with peak detector. Quasi-Peak and Average measurement were performed at the frequencies with maximized peak emission were detected.



# **APPENDIX 1 PHOTOS OF TEST SETUP**

See test photos attached in Appendix 1 for the actual connections between Product and support equipment.

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# **APPENDIX 2 PHOTOS OF EUT CONSTRUCTIONAL DETAILS**

